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# EE C245 - ME C218 Introduction to MEMS Design Fall 2010

Prof. Clark T.-C. Nguyen

Dept. of Electrical Engineering & Computer Sciences  
University of California at Berkeley  
Berkeley, CA 94720

Lecture Module 4: Lithography, Etching, & Doping

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## Lecture Outline

- Reading: Senturia, Chpt. 3; Jaeger, Chpt. 2, 4, 5
  - ↳ Lithography
  - ↳ Etching
    - Wet etching
    - Dry etching
  - ↳ Semiconductor Doping
    - Ion implantation
    - Diffusion

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# Lithography

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## Lithography

**Lithography**  
↳ Method for massive patterning of features on a wafer → pattern billions of devices in just a few steps

**Four Main Components (that affect resolution)**

- I. Radiation Source
- II. Mask
- III. Photoresist
- IV. Exposure System

The diagram illustrates the lithography process. At the top, a radiation source (I) emits light through a mask (II) which has a designated pattern (clear or dark field). The mask is placed on a wafer. The wafer has a photoresist layer (~1 μm-thick) and a film to be patterned (e.g., poly-Si). The photoresist is generated from layout (emulsion or chrome). The exposure system (IV) is used to expose the photoresist through the mask. The exposure system can be contact, step and repeat, or optics. The text notes that optics is where the real art is.

emulsion    chrome

Generated from layout

Mask (glass/quartz)

Photoresist (~1 μm-thick)

Film to be patterned (e.g., poly-Si)

contact, step and repeat

optics → this is where the real art is!

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### Lithography (cont.)

The basic Process - (Positive Resist Example)

Exposed PR → converts to another form after reaction with light (e.g., (+)-resist: polymer → organic acid)

Dip or spray wafer with developer → if (+) resist, developer is often a base

Etch → PR protects film; open areas of film get etched

Remove PR

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### Lithography (cont.)

With each masking step usually comes a film deposition, implantation and/or etch. Thus, the complexity of a process is often measured by # masks required.

- NMOS: 4-6 masks
- Bipolar: 8-15 masks
- BICMOS: ~20 masks
- CMOS: 8-28 masks

↖ Multi-level metallization

- Comb-Drive Resonator: 3 masks
- GHz Disk: 4 masks

Now, take a closer look at the 4 components:

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### I. Radiation Source

I. Radiation Source

Several types: optical (visible, UV, deep UV light), e-beam, X-ray, ion beam

The shorter the wavelength → Better the resolution

Today's prime choice due to cost and throughput.

Can expose billions of devices at once!

Optical Sources:

- Mercury arc lamp (mercury vapor discharge)

	200	365	405	435	546 nm
	I-line	G-line			

we have all of these in our μlab

For deep UV, need Excimer laser (very expensive)

Glass opaque, so must use quartz mask and lens

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### II. Mask

II. Mask → has become one of today's biggest bottlenecks!

Electronic computer representation of layout (e.g., CIF, GDSII)

⇒ A single file contains all layers

↓ tape → mask generator

Masks for each layer

Mask Material:

- Fused silica (glass) → inexpensive, but larger thermal expansion coeff.
- Quartz → expensive, but smaller thermal expansion coeff.

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